

Search Notes

Application/Control No.

10/658,630

Examiner

Simon A. Goetze

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2617

SEARCHED

Class	Subclass	Date	Examiner
370	328 338 465 466	2/2/2007	SAG
398	58 59 60 61	2/2/2007	SAG
398	62 63 64	2/2/2007	SAG
REVIEW	ABOVE	7/10/2007	SAG

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST image and keyword search (USPAT; US-PGPUB; USOCR; EPO; JPO; DERWENT; IBM_TDB).	2/2/2007	SAG
Consulted with Edan Orgad (Class 455), Chau T. Nguyen and Melvin Marcelo (both of Class 370).	2/2/2007	SAG